Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/664,777	IWASE, HIROYUKI	
Examiner	Art Unit	
M. Lee	2622	

SEARCHED			
Class	Subclass	Date	Examiner
348	722, 589	4/27/2006	ML
	570	11/30/06	me
	575	7	
	578		
	584		
	594		
	595		
	705		
	706		
386	52		
715	723		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			
		<u> </u>	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	4/27/2006	ML
updated	11/30/06	ml